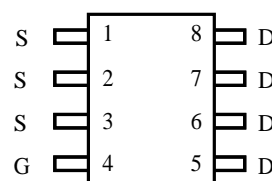


P -Channel High Density TrenchMOSFET

Features:

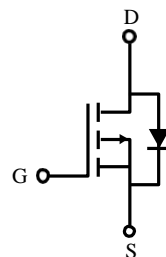
- Super high dense cell trench design for low RDS(on).
- Rugged and reliable.
- Surface Mount package.

SOP-8



PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(on)}$ (m Ω) Max	I_D
-30V	12 @ $V_{GS} = -10V$	-18A
	17 @ $V_{GS} = -4.5V$	



ABSOLUTE MAXIMUM RATINGS (TA = 25 °C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	-30	V
Gate-Source Voltage	V_{GS}	± 25	V
Drain Current-Continuous (Note 1)	I_D	$T_A = 25\text{ }^\circ\text{C}$	-18
		$T_A = 70\text{ }^\circ\text{C}$	-13
Pulse Drain Current (Note 2)	I_{DM}	-60	A
Avalanche Current	I_{AS}	-30	
Single Pulse Avalanche Energy	E_{AS}	41	mJ
Maximum Power Dissipation (Note 1)	P_D	$T_A = 25\text{ }^\circ\text{C}$	3.1
		$T_A = 75\text{ }^\circ\text{C}$	2.0
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	$^\circ\text{C}$

THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Case (Note 1)	R_{thJC}	6	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Ambient (Note 1)	R_{thJA}	40	$^\circ\text{C/W}$

Note:

1. Surface Mounted on FR4 Board, $t \leq 10\text{sec}$.
2. Pulse width limited by maximum junction temperature

ELECTRICAL CHARACTERISTICS (TA = 25 °C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS} = 0V, I_D = -250\mu A$	-30			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -24V, V_{GS} = 0V, T_j = 25^\circ C$			-1	uA
		$V_{DS} = -20V, V_{GS} = 0V, T_j = 125^\circ C$			-10	
Gate-Body Leakage	I_{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$			± 100	nA
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\mu A$	-1	-1.6	-2.5	V
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = -10V, I_D = -12A$		9.7	12	m Ω
		$V_{GS} = -4.5V, I_D = -9A$		13.5	17	m Ω
Forward Transconductance	gfs	$V_{DS} = -10V, I_D = -12A$		30		S
DYNAMIC CHARACTERISTICS (Note 4)						
Input Capacitance	C_{ISS}			2550		pF
Output Capacitance	C_{OSS}	$V_{DS} = -15V, V_{GS} = 0V$ $f = 1.0MHz$		370		pF
Reverse Transfer Capacitance	C_{RSS}			286		pF
Gate Resistance	R_g	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$		9.5		Ω
SWITCHING CHARACTERISTICS (Note 4)						
Turn-On Delay Time	$t_{d(ON)}$	$V_{DD} = -15V, I_D = -1A, V_{GS} = -10V, R_{GS} = 6\Omega$		18		nS
Rise Time	tr			24		nS
Turn-Off Delay Time	$t_{d(OFF)}$			88		nS
Fall Time	tf			24		nS
Total Gate Charge (10V)	Qg	$V_{DS} = -15V, I_D = -12A$ $V_{GS} = -10V$		62		nC
Total Gate Charge (4.5V)	Qg			33		nC
Gate-Source Charge	Qgs			8.8		nC
Gate-Drain Charge	Qgd			16		nC
DRAIN-SOURCE DIODE CHARACTERISTICS						
Drain-Source Diode Forward Current (Note 1)	I_S				-4.5	A
Diode Forward Voltage (Note 3)	V_{SD}	$V_{GS} = 0V, I_F = I_S$		-0.75	-1.1	V

Note:

3. Pulse Test Pulse width $\leq 300\mu s$, Duty Cycle $\leq 2\%$.

4. Guaranteed by design, not subject to production testing.

